

**Notice of References Cited**

Application/Control No.

09/521,235

Applicant(s)/Patent Under

Reexamination

SWAMINATHAN ET AL.

Examiner

Maikhanh Nguyen

Art Unit

2176

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,864,871	01-1999	Kitain et al.	707/104.1
	B	US-6,564,209	05-2003	Dempski et al.	707/3
	C	US-2001/0056418	12-2001	Youn, Seok Ho	707/3
	D	US-5,802,518	09-1998	Karaev et al.	707/9
	E	US-6,029,141	02-2000	Bezos et al.	705/27
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.